Search Notes			

Application No.	Applicant(s)	
10/066,456	TEIG ET AL.	
Examiner	Art Unit	
Binh C. Tat	2825	

SEARCHED				
Class	Subclass	Date	Examiner	
716	1-18	9/30/2004	вт	
714	2,14-16	9/30/2004	ВТ	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	1-18	9/30/2004	ВТ
716	2,14-16	9/30/2004	ВТ

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST SEARCH	9/30/2004	вт
IEEE	9/30/2004	ВТ